

COMPLIANT

### STP6NK90Z-VB Datasheet

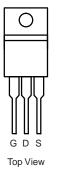
## N-Channel 900V (D-S) Super Junction Power MOSFET

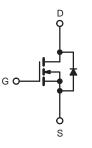
| PRODUCT SUMMARY            |                            |  |  |  |  |
|----------------------------|----------------------------|--|--|--|--|
| V <sub>DS</sub> (V)        | 900                        |  |  |  |  |
| R <sub>DS(on)</sub> (Ω)    | V <sub>GS</sub> = 10 V 1.3 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 200                        |  |  |  |  |
| Q <sub>gs</sub> (nC)       | 24                         |  |  |  |  |
| Q <sub>gd</sub> (nC)       | 110                        |  |  |  |  |
| Configuration              | Single                     |  |  |  |  |

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>              | = 25 °C, unl            | ess otherwis                      | se noted)        |       |          |  |
|---|-------------------------|-----------------------------------|------------------|-------|----------|--|
| PARAMETER   |                         |                                   | SYMBOL           | LIMIT | UNIT     |  |
| Drain-Source Voltage                                  |                         |                                   | V <sub>DS</sub>  | 900   | V        |  |
| Gate-Source Voltage                                   |                         |                                   | V <sub>GS</sub>  | ± 20  | v        |  |
| Continuous Drain Current                              | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C            | I <sub>D</sub>   | 5     |          |  |
| Continuous Drain Current                              |                         | T <sub>C</sub> = 100 °C           |                  | 3.9   | A        |  |
| Pulsed Drain Current <sup>a</sup>                     |                         |                                   | I <sub>DM</sub>  | 21    |          |  |
| Linear Derating Factor                                |                         |                                   |                  | 1.5   | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>            |                         |                                   | E <sub>AS</sub>  | 770   | mJ       |  |
| Repetitive Avalanche Current <sup>a</sup>             |                         |                                   | I <sub>AR</sub>  | 7.8   | A        |  |
| Repetitive Avalanche Energy <sup>a</sup>              |                         |                                   | E <sub>AR</sub>  | 19    | mJ       |  |
| Maximum Power Dissipation T <sub>C</sub> = 25 °C      |                         | PD                                | 190              | W     |          |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                |                         |                                   | dV/dt            | 2.0   | V/ns     |  |
| Operating Junction and Storage Temperature Range      |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150    | °C    |          |  |
| Soldering Recommendations (Peak Temperature) for 10 s |                         | -                                 | 300 <sup>d</sup> |       |          |  |
| Mounting Torque                                       | 6-32 or M3 screw        |                                   |                  | 10    | lbf ∙ in |  |
|   |                         |                                   | Ē                | 1.1   | N · m    |  |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 23 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 7.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 7.8 \text{ A}$ , dI/dt  $\leq 140 \text{ A/}\mu\text{s}$ ,  $V_{DD} \leq 600 \text{ V}$ ,  $T_J \leq 150 \text{ °C}$ .

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

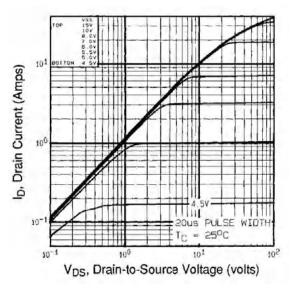
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| THERMAL RESISTANCE RATI                          | NGS                   |  |  |   |           |                       |       |         |  |
|--|-----------------------|--|--|---|-----------|-----------------------|-------|---------|--|
| PARAMETER  | SYMBOL                | TYP.   |  | MAX.  |           | UNIT                  |       |         |  |
| Maximum Junction-to-Ambient                      | R <sub>thJA</sub>     | -  |  | 40  |           |                       |       |         |  |
| Case-to-Sink, Flat, Greased Surface              | R <sub>thCS</sub>     | 0.24   |  | -   |           | °C/W                  |       |         |  |
| Maximum Junction-to-Case (Drain)                 | R <sub>thJC</sub>     | - 0.65   |  |   |           | ]                     |       |         |  |
| <b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u | nless otherwi         | se noted)  |  |   |           |                       |       |         |  |
| PARAMETER  | SYMBOL                | 1  | T CONDIT   | IONS  | MIN.      | TYP.                  | MAX.  | UNIT    |  |
| Static   |                       |  |  |   |           | I                     | I     | <b></b> |  |
| Drain-Source Breakdown Voltage                   | V <sub>DS</sub>       | V <sub>GS</sub> :  | = 0 V, I <sub>D</sub> = 2  | 250 µA  | 900       | -                     | -     | V       |  |
| V <sub>DS</sub> Temperature Coefficient          | $\Delta V_{DS}/T_{J}$ | Referenc   | e to 25 °C,  | I <sub>D</sub> = 1 mA                                   | -         | 0.98                  | -     | V/°C    |  |
| Gate-Source Threshold Voltage                    | V <sub>GS(th)</sub>   | V <sub>DS</sub> =  | = V <sub>GS</sub> , I <sub>D</sub> = 1                                       | 250 µA  | 2.0       | -                     | 4.0   | V       |  |
| Gate-Source Leakage                              | I <sub>GSS</sub>      |  | $V_{GS} = \pm 20$  | V   | -         | -                     | ± 100 | nA      |  |
|  |                       | V <sub>DS</sub> =  | = 800 V, V <sub>G</sub>  | <sub>S</sub> = 0 V                                      | -         | -                     | 100   | μA      |  |
| Zero Gate Voltage Drain Current                  | IDSS                  | V <sub>DS</sub> = 640 \  | /, V <sub>GS</sub> = 0 \   | /, T <sub>J</sub> = 125 °C                              | -         | -                     | 500   |         |  |
| Drain-Source On-State Resistance                 | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V   | I <sub>D</sub>   | = 3.7 A <sup>b</sup>                                    | -         | 1.3                   | -     | Ω       |  |
| Forward Transconductance                         | <b>g</b> fs           | V <sub>DS</sub> =  | = 100 V, I <sub>D</sub> =  | = 3.7 A <sup>b</sup>                                    | 5.6       | -                     | -     | S       |  |
| Dynamic  |                       |  |  |   |           |                       |       |         |  |
| Input Capacitance                                | C <sub>iss</sub>      |  | V <sub>GS</sub> = 0 V  |   | -         | 3100                  | -     |         |  |
| Output Capacitance                               | C <sub>oss</sub>      | 1  | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 25 V,<br>f = 1.0 MHz, see fig. 5 |   | -         | 800                   | -     | pF      |  |
| Reverse Transfer Capacitance                     | C <sub>rss</sub>      | f = 1  |  |   | -         | 490                   | -     |         |  |
| Total Gate Charge                                | Qg                    |  |  |   | -         | -                     | 200   |         |  |
| Gate-Source Charge                               | Q <sub>gs</sub>       | $V_{GS} = 10 V$  |  | A, V <sub>DS</sub> = 400 V,<br>g. 6 and 13 <sup>b</sup> | -         | -                     | 24    | nC      |  |
| Gate-Drain Charge                                | Q <sub>gd</sub>       | 1  | 300 1  | 9. 0 414 10   | -         | -                     | 110   |         |  |
| Turn-On Delay Time                               | t <sub>d(on)</sub>    |  |  |   | -         | 19                    | -     | ns      |  |
| Rise Time  | tr                    |  | = 400 V, I <sub>D</sub> =  |   | -         | 38                    | -     |         |  |
| Turn-Off Delay Time                              | t <sub>d(off)</sub>   | R <sub>g</sub> =   | = 6.2 Ω, R <sub>D</sub> =  | = 52 Ω<br><sub>b</sub>                                  | -         | 120                   | -     |         |  |
| Fall Time  | t <sub>f</sub>        | 1  | see fig. 10 <sup>b</sup>   |   | -         | 39                    | -     | 1       |  |
| Internal Drain Inductance                        | L <sub>D</sub>        | Between lead<br>6 mm (0.25") f   | from   |   | -         | 5.0                   | -     |         |  |
| Internal Source Inductance                       | L <sub>S</sub>        | package and center of die contact  |  | -   | 13        | -                     | nH    |         |  |
| Drain-Source Body Diode Characteristic           | s                     | •  |  |   |           | •                     |       | •       |  |
| Continuous Source-Drain Diode Current            | I <sub>S</sub>        | MOSFET symbol<br>showing the<br>integral reverse<br>p - n junction diode         |  | -   | -         | 5.0                   | A     |         |  |
| Pulsed Diode Forward Current <sup>a</sup>        | I <sub>SM</sub>       |  |  | -   | -         | 21                    |       |         |  |
| Body Diode Voltage                               | V <sub>SD</sub>       | $T_J$ = 25 °C, $I_S$ = 3.8 A, $V_{GS}$ = 0 V <sup>b</sup>                        |  | -   | -         | 1.8                   | V     |         |  |
| Body Diode Reverse Recovery Time                 | t <sub>rr</sub>       | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A,<br>dl/dt = 100 A/μs <sup>b</sup> |  | -   | 650       | 980                   | ns    |         |  |
| Body Diode Reverse Recovery Charge               | Q <sub>rr</sub>       |  |  | -   | 3.8       | 5.7                   | μC    |         |  |
| Forward Turn-On Time                             | t <sub>on</sub>       | Intrinsic turn-on time is negligible (turn                                       |  | -on is dor  | ninated h | $_{\rm by L_{S}}$ and | Ln)   |         |  |

#### Notes

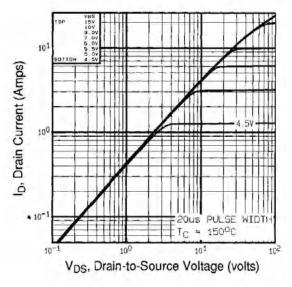
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







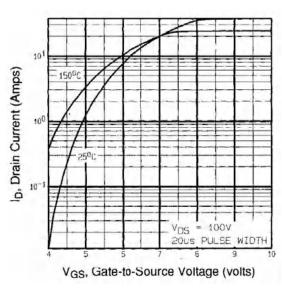
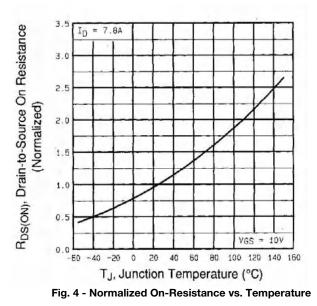


Fig. 3 - Typical Transfer Characteristics





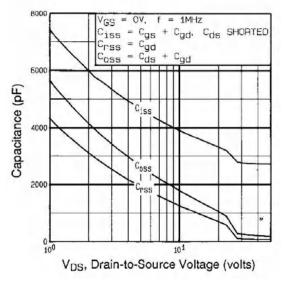


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

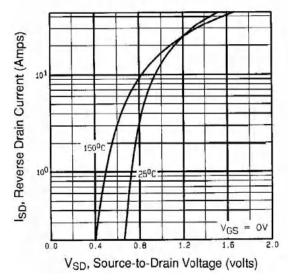


Fig. 7 - Typical Source-Drain Diode Forward Voltage

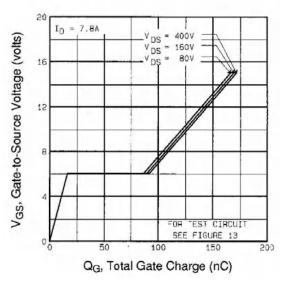
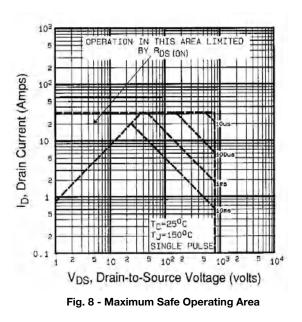


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





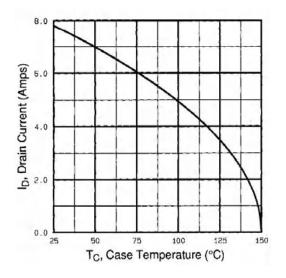


Fig. 9 - Maximum Drain Current vs. Case Temperature

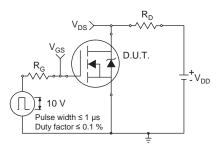


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

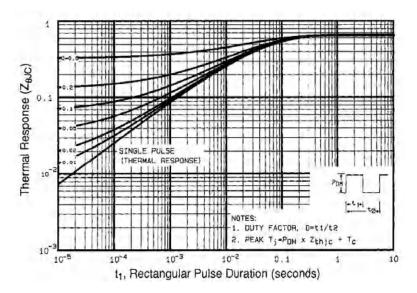


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



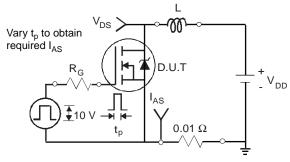


Fig. 12a - Unclamped Inductive Test Circuit

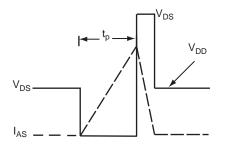


Fig. 12b - Unclamped Inductive Waveforms

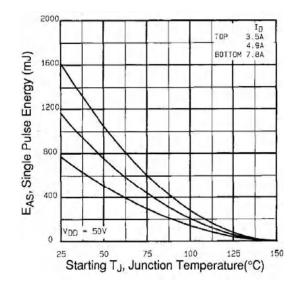


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

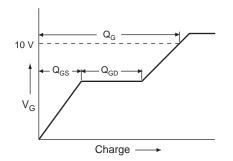


Fig. 13a - Basic Gate Charge Waveform

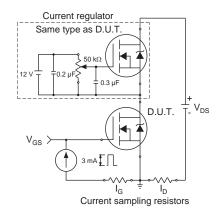
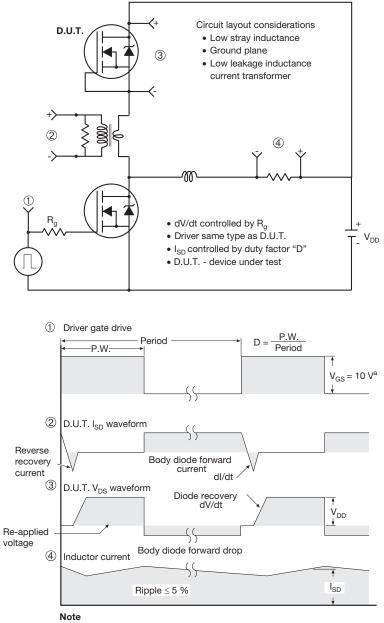


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

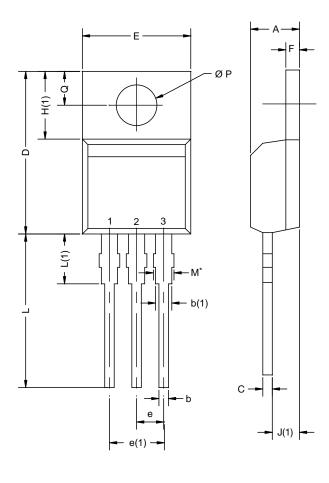


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



# **TO-220AB**



|                       | MILLIN            | IETERS    | INC   | HES   |  |
|-----------------------|-------------------|-----------|-------|-------|--|
| DIM.                  | MIN.              | MAX.      | MIN.  | MAX.  |  |
| А                     | 4.25              | 4.65      | 0.167 | 0.183 |  |
| b                     | 0.69              | 1.01      | 0.027 | 0.040 |  |
| b(1)                  | 1.20              | 1.73      | 0.047 | 0.068 |  |
| С                     | 0.36              | 0.61      | 0.014 | 0.024 |  |
| D                     | 14.85             | 15.49     | 0.585 | 0.610 |  |
| E                     | 10.04             | 10.51     | 0.395 | 0.414 |  |
| е                     | 2.41              | 2.67      | 0.095 | 0.105 |  |
| e(1)                  | 4.88              | 5.28      | 0.192 | 0.208 |  |
| F                     | 1.14              | 1.40      | 0.045 | 0.055 |  |
| H(1)                  | 6.09              | 6.48      | 0.240 | 0.255 |  |
| J(1)                  | 2.41              | 2.92      | 0.095 | 0.115 |  |
| L                     | 13.35             | 14.02     | 0.526 | 0.552 |  |
| L(1)                  | 3.32              | 3.82      | 0.131 | 0.150 |  |
| ØР                    | 3.54              | 3.94      | 0.139 | 0.155 |  |
| Q                     | 2.60              | 3.00      | 0.102 | 0.118 |  |
| ECN: X12-<br>DWG: 547 | 0208-Rev. N,<br>1 | 08-Oct-12 |       |       |  |

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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